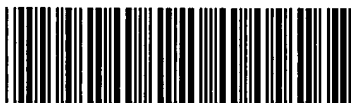


Search Notes

Application/Control No.

10/603,620

Examiner

Ali Bayat

Applicant(s)/Patent under
Reexamination

HWANG ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	236,237,2 39,240,23 2,233,305	10/19/2006	A.B
375	240.19	10/19/2006	A.B
375	240.03	10/19/2006	A.B
375	240.11	10/19/2006	A.B
updated	above	10/20/2006	A.B

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
USPGPUB	TEXT	10/19/2006	A.B
USPGPUB	search	10/19/2006	A.B
Interference search print out		10/19/2006	A.B

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST(USPGPUB; USPAT; DERWENT; EPO;JPO;IBM-TEB); IEEE XPLORE; see text search history print out	10/19/2006	A.B
see interference search history print out.	10/19/2006	A.B
Consulted with Jingge Wu and Wenpeng Chen	10/19/2006	A.B